

Enhancement Mode N-Channel Power MOSFET

SOT23/NMOS/36V/ \pm 12V/1.0V/5A/39m Ω

Rev0.6





36V, 39mΩ, 5A, Single N-Channel

1.Features

- ♦ 36V MOSFET technology
- Low on-state resistance
- Fast switching
- Vgs±12V

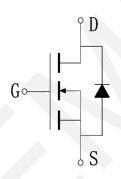
2.Appl	ications
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- Power Switching Application
- Load Switching



Pin Description

 V_{DS} $R_{DS(on)}$ Typ. I_D Max. $39m\Omega @ 10V$ 36V 41mΩ @4.5V 5 A 52mΩ @2.5V



Schematic Diagram

3. Package Marking and Ordering Information

Part no.	Marking	Package	PCS/Reel	PCS/CTN.
WP3400DSS	3400D	SOT23	3,000	180,000

4.Absolute Max Ratings at Ta=25°C (Note1)

Parameter	Symbol	Maximum	Units
Drain to Source Voltage	V _{DSS}	36	V
Gate to Source Voltage	V _{GSS}	±12	V
Drain Current (DC)	ID	5	А
Drain Current (Pulse), PW≤300μs	I _{DP}	20	А
Total Dissipation	P _D	1.2	W
Junction Temperature	Tj	150	°C
Storage Temperature	T _{stg}	-55 to +150	°C

Note 1: Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.



5. Thermal Resistance Ratings (Note 2)

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-Ambient	Reja	103	°C/W

Note 2: When mounted on 1 inch square copper board $t \le 10$ sec The value in any given application depends on the user's specific board design.

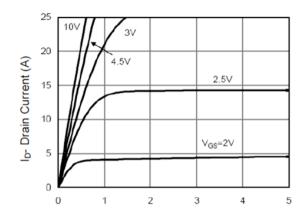
6.Electrical Characteristics at Ta=25°C (Note 3)

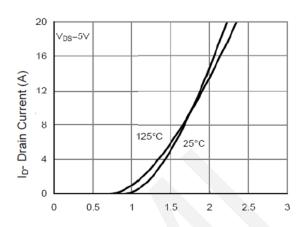
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Units
Drain to Source Breakdown Voltage	V _{(BR)DSS}	$I_D = 250 \mu A$, $V_{GS} = 0 V$	36	-	-	V
Zero-Gate Voltage Drain Current	I _{DSS}	V _{DS} = 36V, V _{GS} = 0V	-	ı	1	μA
Gate to Source Leakage Current	Igss	$V_{GS} = \pm 12V, V_{DS} = 0V$	-	-	±100	nA
Gate Threshold Voltage	V _{GS(th)}	V _{DS} =V _{GS} , I _{DS} =250µA	0.5	1.0	1.5	V
		I _D = 5A, V _{GS} =10V	Í	39	45	mΩ
Static Drain to Source On-State Resistance	R _{DS(on)}	I _D = 4A, V _{GS} = 4.5V	-	41	50	mΩ
11633611166		I _D = 3A, V _{GS} = 2.5V	-	52	65	mΩ
Input Capacitance	Ciss	V _{GS} =0V,	-	820	-	pF
Output Capacitance	Coss	V _{DS} =15V, Frequency=1.0MHz	-	99	-	pF
Reverse Transfer Capacitance	Crss		-	77	-	pF
Turn-ON Delay Time	t _{d(on)}		-	3.3	-	ns
Rise Time	tr	$V_{DD} = 15V, R_{L}=2.7\Omega$	-	4.8	-	ns
Turn-OFF Delay Time	t _{d(off)}	$V_{GS} = 10V$, $R_G = 3\Omega$	-	26	-	ns
Fall Time	t _f		-	4	-	ns
	Qg	V _{DS} = 15V,	-	9.5	-	nC
Total Gate Charge	Qgs	V _{GS} =4.5V, I _D = 5A	-	1.5	-	nC
	Q _{gd}		-	3	-	nC
Diode Forward Voltage	V _{FSD}	I _S = 5A, V _{GS} = 0	0.5	-	1.2	V

Note 3: Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.



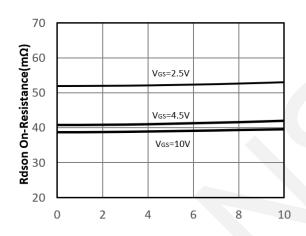
7. Typical Electrical and Thermal Characteristics

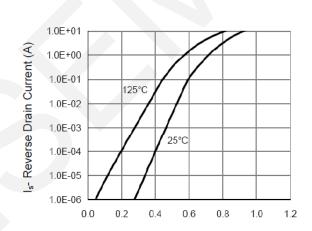




Output Characteristics

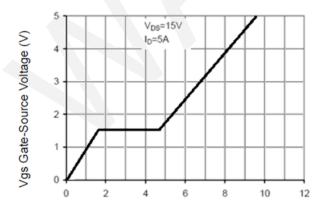


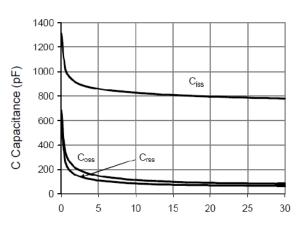




On-resistance vs. Drain Current

Body Diode Characteristics

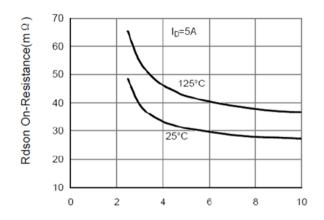


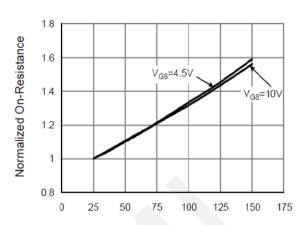


Gate Charge Characteristics

Capacitance Characteristics



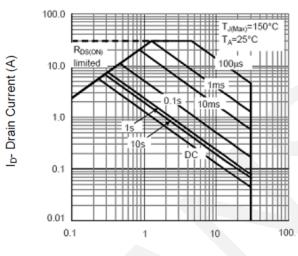


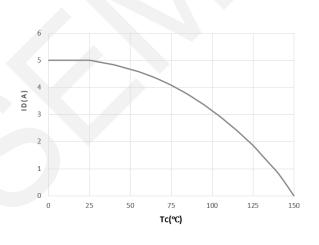


Rdson vs Vgs

Normalized on Resistance vs.

Junction Temperature

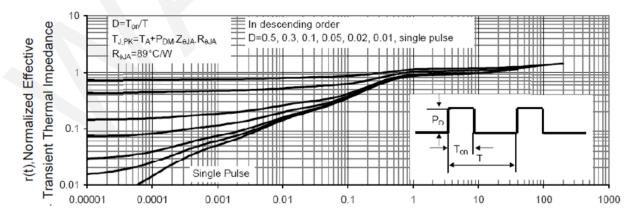




Maximum Safe Operating Area

Maximum Continuous Drain Current vs.

Case Temperature

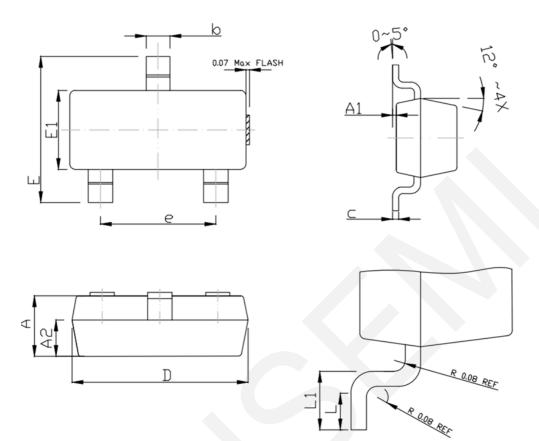


Maximum Effective Transient

Thermal Impedance, Junction-to-Case



8.Package Dimensions



CVMDOL	MILLIMETER			
SYMBOL	MIN	NOM	MAX	
A	0. 95	1.00	1.05	
Al	0. 01	0. 05	0.10	
b	0.35	0. 40	0. 45	
С	0.11 BSC			
D	2. 80	2. 90	3. 00	
E	2. 30	2. 40	2. 50	
E1	1. 20	1.30	1. 40	
е	0. 95BSC			
L	0. 20	0. 20 -		
Ll	0.30	0. 40	0. 50	
A2	0.60 REF			



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